Low-Voltage 1.8/2.5/3.3V 16-Bit Buffer

With 3.6 V–Tolerant Inputs and Outputs (3–State, Non–Inverting)

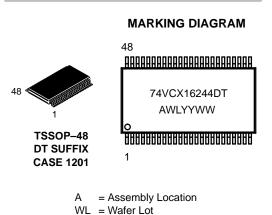
The 74VCX16244 is an advanced performance, non-inverting 16-bit buffer. It is designed for very high-speed, very low-power operation in 1.8 V, 2.5 V or 3.3 V systems.

When operating at 2.5 V (or 1.8 V) the part is designed to tolerate voltages it may encounter on either inputs or outputs when interfacing to 3.3 V busses. It is guaranteed to be over-voltage tolerant to 3.6 V.

The 74VCX16244 is nibble controlled with each nibble functioning identically, but independently. The control pins may be tied together to obtain full 16–bit operation. The 3–state outputs are controlled by an Output Enable (\overline{OEn}) input for each nibble. When \overline{OEn} is LOW, the outputs are on. When \overline{OEn} is HIGH, the outputs are in the high impedance state.

- Designed for Low Voltage Operation: $V_{CC} = 1.65 3.6 \text{ V}$
- 3.6 V Tolerant Inputs and Outputs
- High Speed Operation: 2.5 ns max for 3.0 to 3.6 V
 3.0 ns max for 2.3 to 2.7 V
 6.0 ns max for 1.65 to 1.95 V
- Static Drive: ±24 mA Drive at 3.0 V ±18 mA Drive at 2.3 V ±6 mA Drive at 1.65 V
- Supports Live Insertion and Withdrawal
- I_{OFF} Specification Guarantees High Impedance When $V_{CC} = 0$ V
- Near Zero Static Supply Current in All Three Logic States (20 μA) Substantially Reduces System Power Requirements
- Latchup Performance Exceeds ±250 mA @ 125°C
- ESD Performance: Human Body Model >2000 V; Machine Model >200 V





ORDERING INFORMATION

YY = Year WW = Work Week

Device	Package	Shipping
74VCX16244DT	TSSOP	39 / Rail
74VCX16244DTR	TSSOP	2500 / Reel

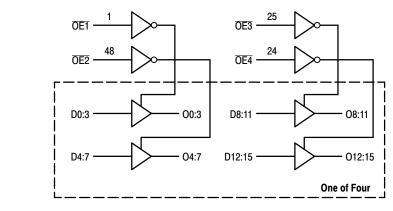


Figure 2. Logic Diagram

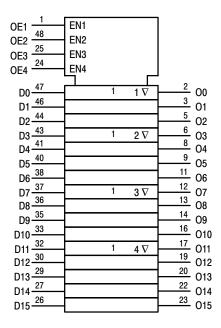


Figure 3. IEC Logic Diagram

		-
0E1 1	\circ	48 <u>0E2</u>
O0 2		47 D0
01 3		46 D1
GND 4		45 GND
O2 5		44 D2
O3 6		43 D3
V _{CC} 7		42 V _{CC}
O4 8		41 D4
O5 9		40 D5
GND 10		39 GND
06 11		38 D6
07 12		37 D7
O8 13		36 D8
09 14		35 D9
GND 15		34 GND
010 16		33 D10
011 17		32 D11
V _{CC} 18		31 V _{CC}
012 19		30 D12
013 20		29 D13
GND 21		28 GND
014 22		27 D14
015 23		26 D15
0E4 24		25 OE3
	L	J

Figure 1. 48–Lead Pinout (Top View)

PIN NAMES

Pins	Function
OEn D0–D15 O0–O15	Output Enable Inputs Inputs Outputs

OE1	D0:3	O0:3	OE2	D4:7	04:7	OE3	D8:11	O8:11	OE4	D12:15	012:15
L	L	L	L	L	L	L	L	L	L	L	L
L	н	Н	L	Н	Н	L	Н	Н	L	Н	Н
Н	Х	Z	Н	Х	Z	Н	Х	Z	Н	Х	Z

H = High Voltage Level; L = Low Voltage Level; Z = High Impedance State; X = High or Low Voltage Level and Transitions Are Acceptable, for I_{CC} reasons, DO NOT FLOAT Inputs

ABSOLUTE MAXIMUM RATINGS*

Symbol	Parameter	Value	Condition	Unit
V _{CC}	DC Supply Voltage	-0.5 to +4.6		V
VI	DC Input Voltage	$-0.5 \le V_I \le +4.6$		V
Vo	DC Output Voltage	$-0.5 \le V_{O} \le +4.6$	Output in 3-State	V
		$-0.5 \le V_O \le V_{CC} + 0.5$	Note 1.; Outputs Active	V
I _{IK}	DC Input Diode Current	-50	V _I < GND	mA
I _{OK}	DC Output Diode Current	-50	V _O < GND	mA
		+50	$V_{O} > V_{CC}$	mA
I _O	DC Output Source/Sink Current	±50		mA
I _{CC}	DC Supply Current Per Supply Pin	±100		mA
I _{GND}	DC Ground Current Per Ground Pin	±100		mA
T _{STG}	Storage Temperature Range	-65 to +150		°C

 * Absolute maximum continuous ratings are those values beyond which damage to the device may occur. Exposure to these conditions or conditions beyond those indicated may adversely affect device reliability. Functional operation under absolute-maximum-rated conditions is not implied.

1. I_O absolute maximum rating must be observed.

RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter		Min	Тур	Max	Unit
V _{CC}	Supply Voltage	Operating Data Retention Only	1.65 1.2	3.3 3.3	3.6 3.6	V
VI	Input Voltage		-0.3		3.6	V
Vo	Output Voltage (Active State) (3–State)		0 0		V _{CC} 3.6	V
I _{OH}	HIGH Level Output Current, V _{CC} = 3.0V – 3.6V				-24	mA
I _{OL}	LOW Level Output Current, V _{CC} = 3.0V – 3.6V				24	mA
I _{OH}	HIGH Level Output Current, $V_{CC} = 2.3V - 2.7V$				-18	mA
I _{OL}	LOW Level Output Current, $V_{CC} = 2.3V - 2.7V$				18	mA
I _{OH}	HIGH Level Output Current, V _{CC} = 1.65V – 1.95V				-6	mA
I _{OL}	LOW Level Output Current, $V_{CC} = 1.65V - 1.95V$				6	mA
T _A	Operating Free–Air Temperature		-40		+85	°C
$\Delta t / \Delta V$	Input Transition Rise or Fall Rate, VIN from 0.8V to	2.0V, V _{CC} = 3.0V	0		10	ns/V

DC ELECTRICAL CHARACTERISTICS

			T _A = -40°0	C to +85°C		
Symbol Characteristic		Condition	Min	Max	Unit	
VIH	HIGH Level Input Voltage (Note 2.)	$1.65V \le V_{CC} < 2.3V$	0.65 x V _{CC}		V	
		$2.3V \le V_{CC} \le 2.7V$	1.6			
		$2.7V < V_{CC} \le 3.6V$	2.0			
V _{IL}	LOW Level Input Voltage (Note 2.)	$1.65V \le V_{CC} < 2.3V$		0.35 x V _{CC}	V	
		$2.3V \le V_{CC} \le 2.7V$		0.7		
		$2.7V < V_{CC} \le 3.6V$		0.8		
V _{OH}	HIGH Level Output Voltage	$1.65V \le V_{CC} \le 3.6V; I_{OH} = -100\mu A$	$V_{CC} - 0.2$		V	
		V _{CC} = 1.65V; I _{OH} = -6mA	1.25			
		V _{CC} = 2.3V; I _{OH} = -6mA	2.0			
		V _{CC} = 2.3V; I _{OH} = -12mA	1.8			
		V _{CC} = 2.3V; I _{OH} = -18mA	1.7			
		V _{CC} = 2.7V; I _{OH} = -12mA	2.2			
		V _{CC} = 3.0V; I _{OH} = -18mA	2.4			
		V _{CC} = 3.0V; I _{OH} = -24mA	2.2			
V _{OL}	LOW Level Output Voltage	$1.65V \le V_{CC} \le 3.6V; I_{OL} = 100\mu A$		0.2	V	
		V _{CC} = 1.65V; I _{OL} = 6mA		0.3		
		V _{CC} = 2.3V; I _{OL} = 12mA		0.4		
		V _{CC} = 2.3V; I _{OL} = 18mA		0.6		
		V _{CC} = 2.7V; I _{OL} = 12mA		0.4		
		V _{CC} = 3.0V; I _{OL} = 18mA		0.4		
		V _{CC} = 3.0V; I _{OL} = 24mA		0.55		
l _l	Input Leakage Current	$1.65 \text{V} \leq \text{V}_{CC} \leq 3.6 \text{V}; \ 0 \text{V} \leq \text{V}_{I} \leq 3.6 \text{V}$		±5.0	μA	
I _{OZ}	3–State Output Current	$\begin{array}{l} 1.65 \text{V} \leq \text{V}_{CC} \leq 3.6 \text{V}; \ 0 \text{V} \leq \text{V}_{O} \leq 3.6 \text{V}; \\ \text{V}_{I} = \text{V}_{IH} \ \text{or} \ \text{V}_{IL} \end{array}$		±10	μA	
I _{OFF}	Power-Off Leakage Current	$V_{CC} = 0V; V_1 \text{ or } V_O = 3.6V$		10	μA	
I _{CC}	Quiescent Supply Current (Note 3.)	$1.65V \le V_{CC} \le 3.6V; V_{I} = GND \text{ or } V_{CC}$		20	μA	
		$1.65V \le V_{CC} \le 3.6V; \ 3.6V \le V_I, \ V_O \le 3.6V$		±20	μA	
∆l _{CC}	Increase in I _{CC} per Input	$2.7V < V_{CC} \le 3.6V; V_{IH} = V_{CC} - 0.6V$	1	750	μA	

2. These values of V_I are used to test DC electrical characteristics only.

3. Outputs disabled or 3-state only.

AC CHARACTERISTICS (Note 4.; $t_R = t_F = 2.0ns$; $C_L = 30pF$; $R_L = 500\Omega$)

				Limits					
					T _A = -40°	℃ to +85°C			
			V _{CC} = 3.0)V to 3.6V	V _{CC} = 2.3	SV to 2.7V	V _{CC} = 1.6	5 to 1.95V	
Symbol	Parameter	Waveform	Min	Max	Min	Max	Min	Max	Unit
t _{PLH} t _{PHL}	Propagation Delay Input to Output	1	0.8 0.8	2.5 2.5	1.0 1.0	3.0 3.0	1.5 1.5	6.0 6.0	ns
t _{PZH} t _{PZL}	Output Enable Time to High and Low Level	2	0.8 0.8	3.5 3.5	1.0 1.0	4.1 4.1	1.5 1.5	8.2 8.2	ns
t _{PHZ} t _{PLZ}	Output Disable Time From High and Low Level	2	0.8 0.8	3.5 3.5	1.0 1.0	3.8 3.8	1.5 1.5	6.8 6.8	ns
t _{OSHL} t _{OSLH}	Output-to-Output Skew (Note 5.)			0.5 0.5		0.5 0.5		0.75 0.75	ns

4. For C_L = 50pF, add approximately 300ps to the AC maximum specification.

5. Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device. The specification applies to any outputs switching in the same direction, either HIGH-to-LOW (t_{OSHL}) or LOW-to-HIGH (t_{OSLH}); parameter guaranteed by design.

DYNAMIC SWITCHING CHARACTERISTICS

			T _A = +25°C	
Symbol	Characteristic	Condition	Тур	Unit
V _{OLP}	Dynamic LOW Peak Voltage	V_{CC} = 1.8V, C_L = 30pF, V_{IH} = V_{CC} , V_{IL} = 0V	0.25	V
	(Note 6.)	V_{CC} = 2.5V, C_L = 30pF, V_{IH} = V_{CC} , V_{IL} = 0V	0.6	
		$V_{CC} = 3.3V, C_L = 30pF, V_{IH} = V_{CC}, V_{IL} = 0V$	0.8	
V _{OLV}	Dynamic LOW Valley Voltage	$V_{CC} = 1.8V, C_L = 30pF, V_{IH} = V_{CC}, V_{IL} = 0V$	-0.25	V
	(Note 6.)	V_{CC} = 2.5V, C_L = 30pF, V_{IH} = V_{CC} , V_{IL} = 0V	-0.6	
		$V_{CC} = 3.3 \text{V}, \text{C}_{\text{L}} = 30 \text{p}\text{F}, \text{V}_{\text{IH}} = \text{V}_{CC}, \text{V}_{\text{IL}} = 0 \text{V}$	-0.8	
V _{OHV}	Dynamic HIGH Valley Voltage	$V_{CC} = 1.8V, C_L = 30pF, V_{IH} = V_{CC}, V_{IL} = 0V$	1.5	V
	(Note 7.)	V_{CC} = 2.5V, C_L = 30pF, V_{IH} = V_{CC} , V_{IL} = 0V	1.9	
		V_{CC} = 3.3V, C_L = 30pF, V_{IH} = V_{CC} , V_{IL} = 0V	2.2	

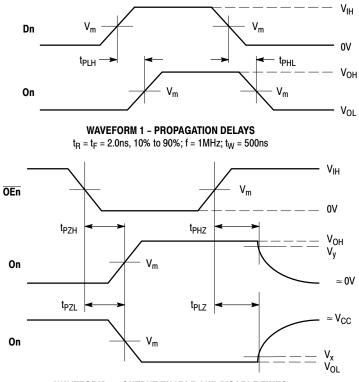
6. Number of outputs defined as "n". Measured with "n-1" outputs switching from HIGH-to-LOW or LOW-to-HIGH. The remaining output is measured in the LOW state. 7. Number of outputs defined as "n". Measured with "n–1" outputs switching from HIGH-to–LOW or LOW-to–HIGH. The remaining output is

measured in the HIGH state.

CAPACITIVE CHARACTERISTICS

Symbol	Parameter	Condition	Typical	Unit
C _{IN}	Input Capacitance	Note 8.	6	pF
C _{OUT}	Output Capacitance	Note 8.	7	pF
C _{PD}	Power Dissipation Capacitance	Note 8., 10MHz	20	pF

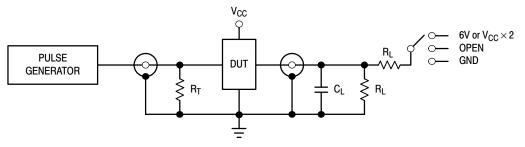
8. V_{CC} = 1.8, 2.5 or 3.3V; V_{I} = 0V or V_{CC} .



WAVEFORM 2 - OUTPUT ENABLE AND DISABLE TIMES t_{R} = t_{F} = 2.0ns, 10% to 90%; f = 1MHz; t_{W} = 500ns

Figure 4. AC Waveforms

	V _{CC}				
Symbol	3.3V ±0.3V	2.5V ±0.2V	1.8V ±0.15V		
V _{IH}	2.7V	V _{CC}	V _{CC}		
V _m	1.5V	V _{CC} /2	V _{CC} /2		
V _x	V _{OL} + 0.3V	V _{OL} + 0.15V	V _{OL} + 0.15V		
Vy	V _{OH} – 0.3V	V _{OH} – 0.15V	V _{OH} – 0.15V		

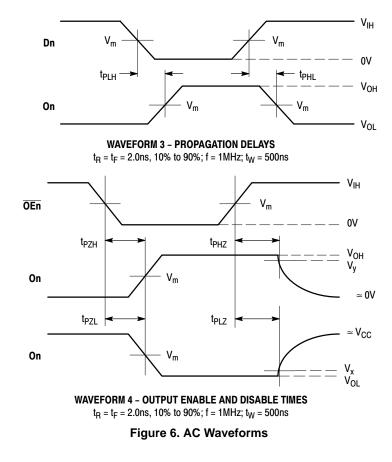


TEST	SWITCH
t _{PLH} , t _{PHL}	Open
t _{PZL} , t _{PLZ}	6V at V _{CC} = 3.3 ± 0.3 V; V _{CC} × 2 at V _{CC} = 2.5 ± 0.2 V; 1.8 ± 0.15 V
t _{PZH} , t _{PHZ}	GND

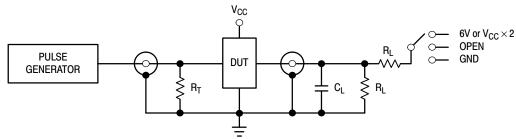
 C_L = 30pF or equivalent (Includes jig and probe capacitance)

 $\begin{array}{l} \mathsf{R}_{\mathsf{L}} = 500\Omega \text{ or equivalent} \\ \mathsf{R}_{\mathsf{T}} = \mathsf{Z}_{\mathsf{OUT}} \text{ of pulse generator (typically 50\Omega)} \end{array}$

Figure 5. Test Circuit



	V _{CC}			
Symbol	3.3V ±0.3V	2.7V		
V _{IH}	2.7V	2.7V		
V _m	1.5V	1.5V		
V _x	V _{OL} + 0.3V	V _{OL} + 0.3V		
Vy	V _{OH} – 0.3V	V _{OH} – 0.3V		



TEST	SWITCH
t _{PLH} , t _{PHL}	Open
t _{PZL} , t _{PLZ}	6V at V _{CC} = 3.3 ±0.3V; V _{CC} × 2 at V _{CC} = 2.5 ±0.2V; 1.8 ±0.15V
t _{PZH} , t _{PHZ}	GND

 C_L = 50pF or equivalent (Includes jig and probe capacitance) R_L = 500 Ω or equivalent

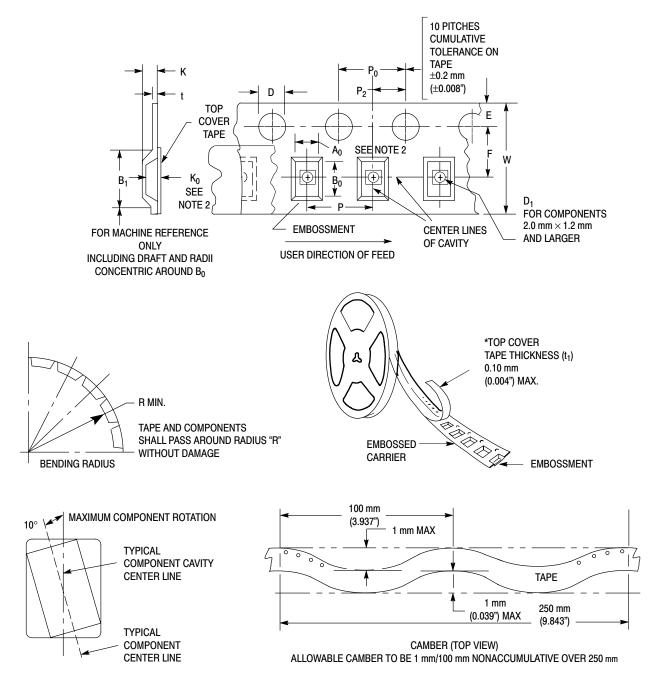
 $R_T = Z_{OUT}$ of pulse generator (typically 50 Ω)

Figure 7. Test Circuit

AC CHARACTERISTICS ($t_R = t_F = 2.0ns$; $C_L = 50pF$; $R_L = 500\Omega$)

			Limits T _A = -40°C to +85°C				-
			V _{CC} = 3.0V to 3.6V		V _{CC} = 2.7V		1
Symbol	Parameter	Waveform	Min	Max	Min	Max	Unit
t _{PLH} t _{PHL}	Propagation Delay Input to Output	3	1.0 1.0	3.0 3.0		3.6 3.6	ns
t _{PZH} t _{PZL}	Output Enable Time to High and Low Level	4	1.0 1.0	4.4 4.4		5.4 5.4	ns
t _{PHZ} t _{PLZ}	Output Disable Time From High and Low Level	4	1.0 1.0	4.1 4.1		4.6 4.6	ns
t _{OSHL} t _{OSLH}	Output-to-Output Skew (Note 9.)			0.5 0.5		0.5 0.5	ns

 Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device. The specification applies to any outputs switching in the same direction, either HIGH–to–LOW (t_{OSHL}) or LOW–to–HIGH (t_{OSLH}); parameter guaranteed by design.





Tape Size	B ₁ Max	D	D ₁	E	F	К	Р	P ₀	P ₂	R	т	w
24mm	20.1mm (0.791")	1.5 + 0.1mm -0.0 (0.059 +0.004" -0.0)	1.5mm Min (0.060")	1.75 ±0.1 mm (0.069 ±0.004")	11.5 ±0.10 mm (0.453 ±0.004")	11.9 mm Max (0.468")	16.0 ±0.1 mm (0.63 ±0.004")	4.0 ±0.1 mm (0.157 ±0.004")	2.0 ±0.1 mm (0.079 ±0.004")	30 mm (1.18")	0.6 mm (0.024")	24.3 mm (0.957")

EMBOSSED CARRIER DIMENSIONS (See Notes 1 and 2)

1. Metric Dimensions Govern-English are in parentheses for reference only.

 A₀, B₀, and K₀ are determined by component size. The clearance between the components and the cavity must be within 0.05 mm min to 0.50 mm max. The component cannot rotate more than 10° within the determined cavity.

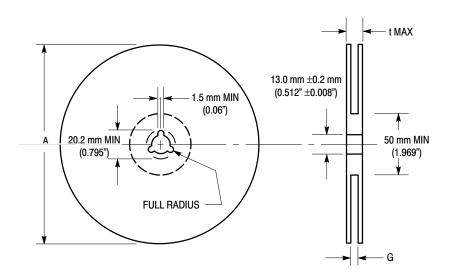
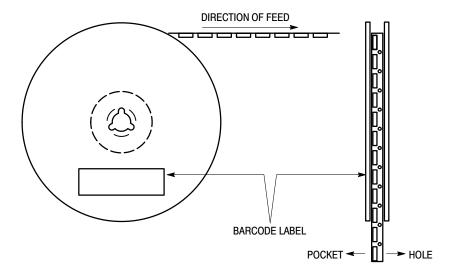


Figure 9. Reel Dimensions

REEL DIMENSIONS

Tape Size	A Max	G	t Max
24 mm	360 mm	24.4 mm + 2.0 mm, -0.0	30.4 mm
	(14.173")	(0.961" + 0.078", -0.00)	(1.197")





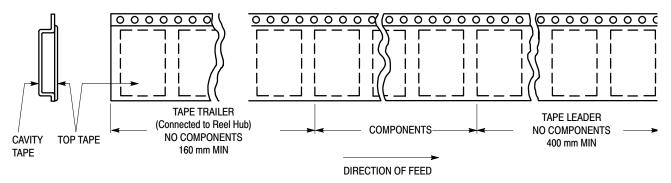
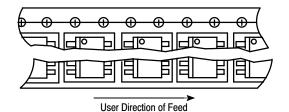


Figure 11. Tape Ends for Finished Goods





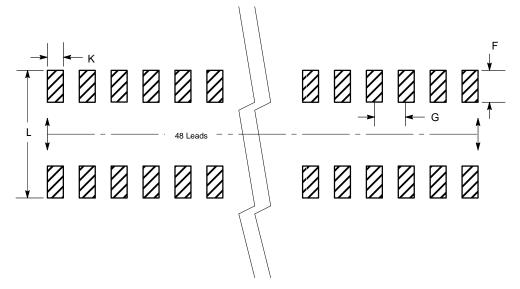
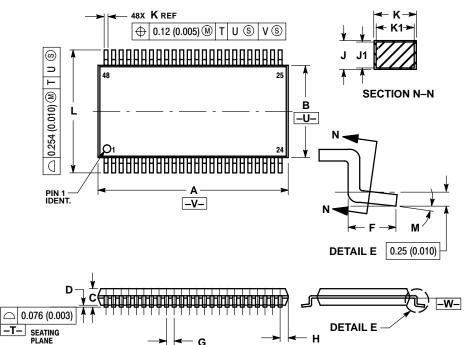


Figure 13. Package Footprint

PACKAGE DIMENSIONS

TSSOP DT SUFFIX CASE 1201-01 ISSUE A



NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- CONTROLLING DIMENSION: MILLIMETER. DIMENSIONS A AND B DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH OR GATE BURRS
- SHALL NOT EXCEED 0.15 (0.006) PER SIDE. DIMENSION K DOES NOT INCLUDE DAMBAR 4
- PROTRUSION R DOES NOT INCLODE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 (0.003) TOTAL IN EXCESS OF THE K DIMENSION AT MAXIMUM MATERIAL CONDITION.
- TERMINAL NUMBERS ARE SHOWN FOR REFERENCE ONLY.
- DIMENSIONS A AND B ARE TO BE DETERMINED AT DATUM PLANE -W-

	MILLIN	IETERS	INCHES		
DIM	MIN	MAX	MIN	MAX	
Α	12.40	12.60	0.488	0.496	
В	6.00	6.20	0.236	0.244	
C		1.10		0.043	
D	0.05	0.15	0.002	0.006	
F	0.50	0.75	0.020	0.030	
G	0.50	BSC	0.0197 BSC		
н	0.37		0.015		
J	0.09	0.20	0.004	0.008	
J1	0.09	0.16	0.004	0.006	
K	0.17	0.27	0.007	0.011	
K1	0.17	0.23	0.007	0.009	
L	7.95	8.25	0.313	0.325	
М	0 °	8 °	0 °	8 °	

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